

OE8000 Hi-Q® RF Test & Measurement System

A fast, fully automated solution for measuring the phase noise spectral density of RF and microwave signal sources across a wide range of frequencies.

Specifications

RMS timing jitter sensitivity : 5 fs (100 Hz - 10 MHz)

Input power range : +5 to + 15 dBm

Spurious: -50 dBc @ <1 kHz offset / -80 dBc @ > 1kHz offset

Resolution bandwidth: 0.1 Hz - 200 kHz

